



cof c

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of

Breitwisch et al.

U.S. Patent No. 6,778,449 <sup>B2</sup>

→ Serial No. 10/064,302

Issued: August 17, 2004

Filed: July 1, 2002

For: METHOD AND DESIGN FOR MEASURING SRAM ARRAY LEAKAGE  
MACRO (ALM)

Certificate  
SEP 01 2004  
of Correction

Commission for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

SUBMISSION OF CERTIFICATE OF CORRECTION

Sir:

Attached herewith are duplicate copies of a Certificate of Correction in connection with the above-identified patent to correct errors in the drawings. It is requested that the Patent Office substitute Figs. 1-5 of the drawings with the attached formal drawings of Figs. 1-5. Please send the certified copy of the Certificate of Correction to the undersigned attorney.

Please charge any deficiencies and credit any overpayments to Attorney's Deposit Account Number 09-0456.

Respectfully submitted,

Dated: 8/20/04

Frederick W. Gibb, III  
Reg. No. 37,629

McGinn & Gibb, P.L.L.C.  
2568-A Riva Road  
Suite 304  
Annapolis, MD 21401  
(301) 261-8071  
Customer Number: 29154

SEP 02 2004

UNITED STATES PATENT AND TRADEMARK OFFICE  
**CERTIFICATE OF CORRECTION**

REGISTRATION NO. :	6,778,449 B2
DATED :	August 17, 2004
INVENTOR(S) :	Breitwisch et al.

It is certified that error appears in the above-identified patent and that said Letters Patent are hereby corrected as shown below:

Please substitute Figs. 1-5 with the attached formal drawings of Figs. 1-5.

MAILING ADDRESS OF SENDER:

Frederick W. Gibb, III  
McGinn & Gibb, PLLC  
2568-A Riva Road  
Suite 304  
Annapolis, MD 21401

PATENT NO. 6,778,449 B2

SEP 02 2004

UNITED STATES PATENT AND TRADEMARK OFFICE  
**CERTIFICATE OF CORRECTION**

REGISTRATION NO. : 6,778,449 B2 ✓

DATED : August 17, 2004

INVENTOR(S) : Breitwisch et al.

It is certified that error appears in the above-identified patent and that said Letters Patent are hereby corrected as shown below:

Please substitute Figs. 1-5 with the attached formal drawings of Figs. 1-5.

MAILING ADDRESS OF SENDER:

Frederick W. Gibb, III  
McGinn & Gibb, PLLC  
2568-A Riva Road  
Suite 304  
Annapolis, MD 21401

PATENT NO. 6,778,449 B2 ✓

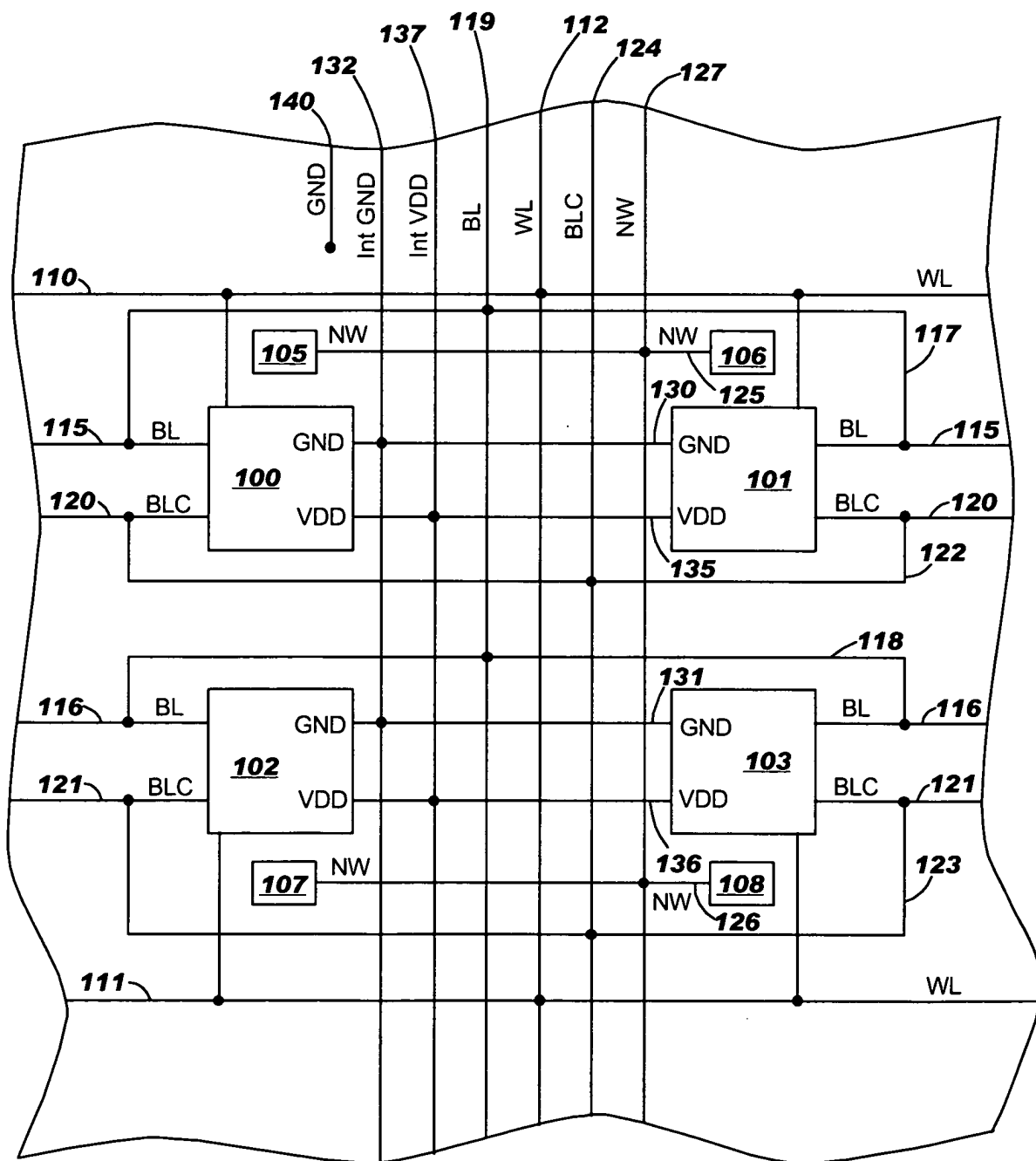
SEP 02 2004

SEP 02 2004

SEP 02 2004

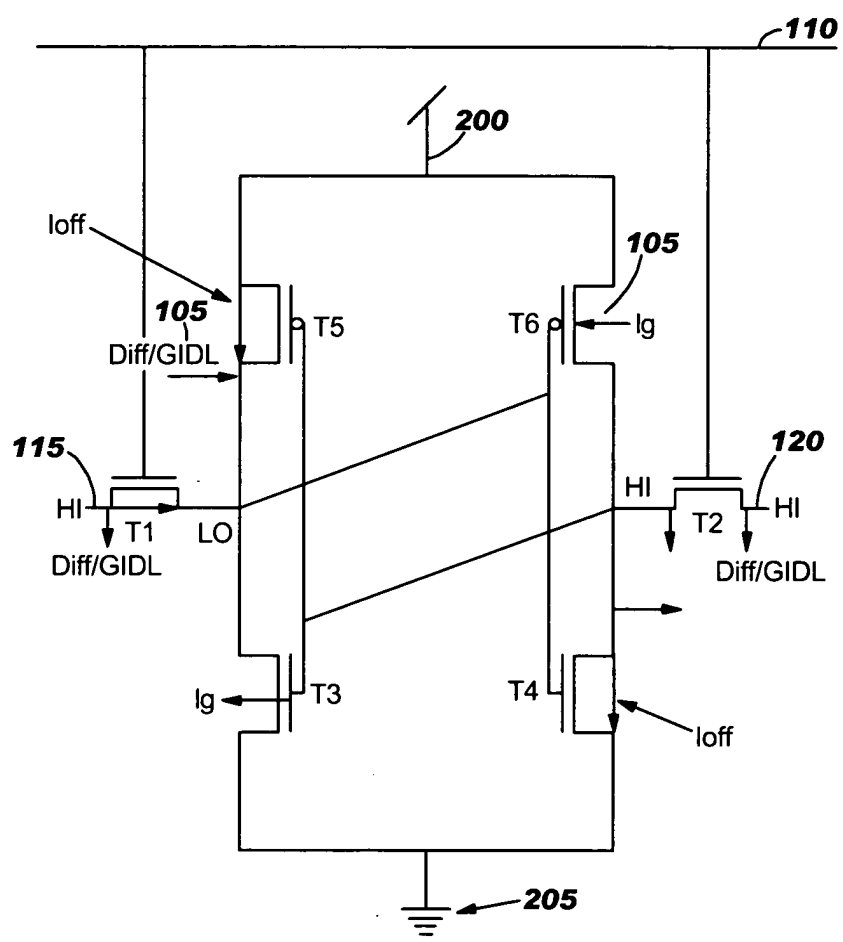


1/4  
FIG. 1





2/4  
FIG. 2



3/4  
FIG. 3

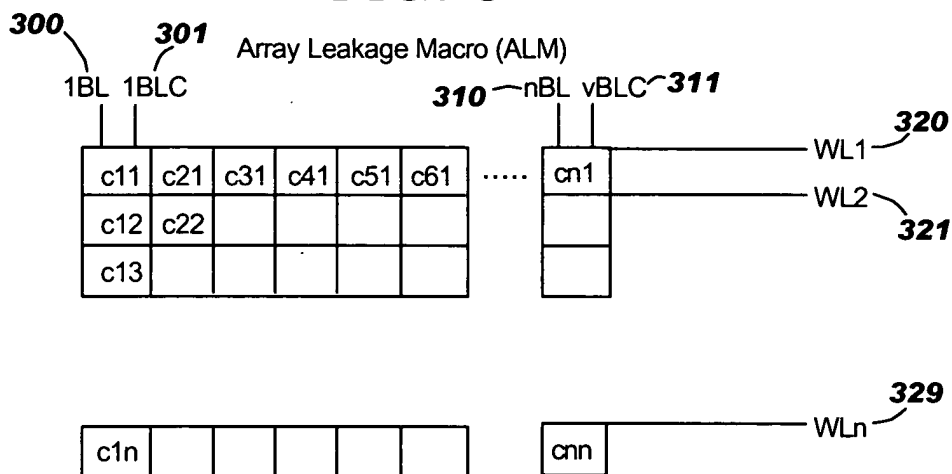
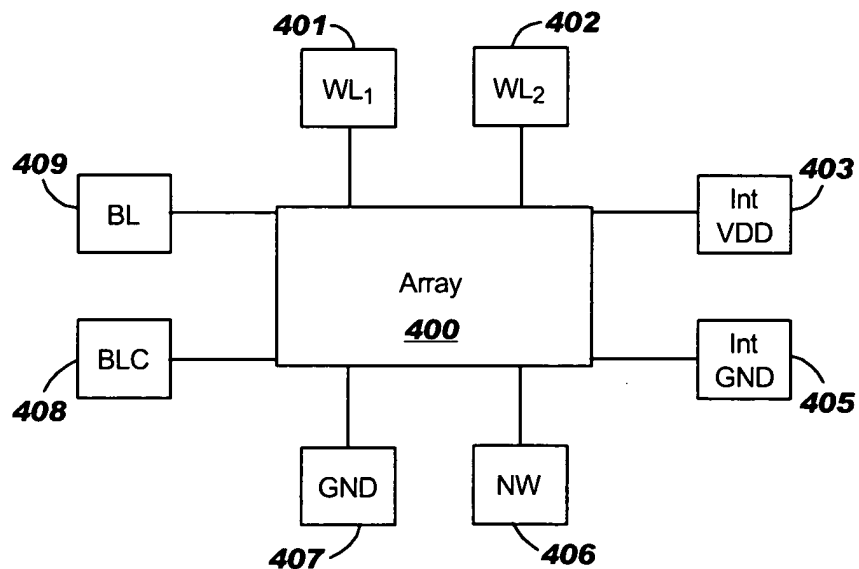


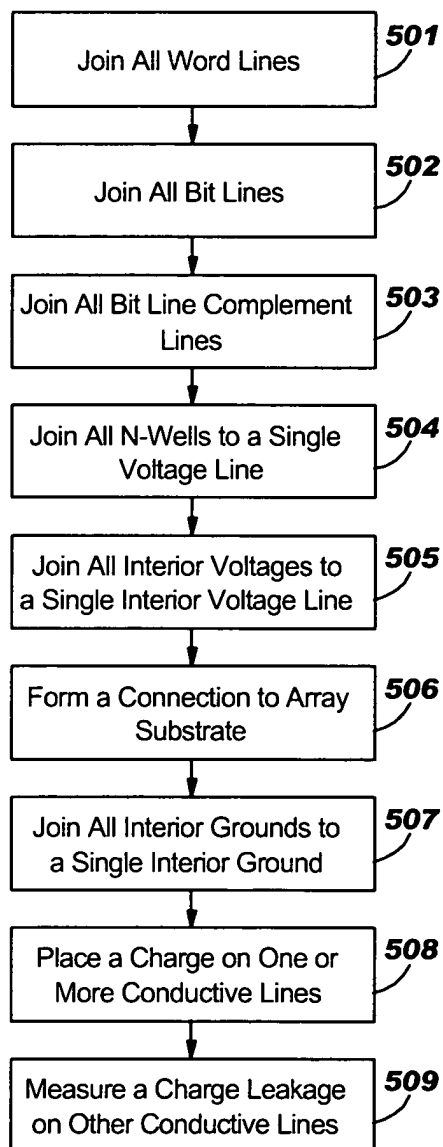
FIG. 4





4/4

FIG. 5



**CERTIFICATE OF MAILING BY FIRST CLASS MAIL (37 CFR 1.8)**Applicant(s): **Breitwisch et al.**

Docket No.

**BUR920010139US1**

Application No.

**10/064,302**

Filing Date

**July 1, 2002**

Examiner

**Auduong, Gene Nghia**

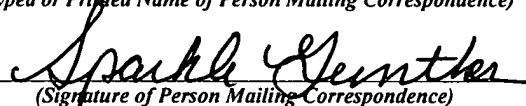
Customer No.

**29154**

Group Art Unit

**2818**Invention: **METHOD AND DESIGN FOR MEASURING SRAM ARRAY LEAKAGE MACRO (ALM)**I hereby certify that this **Certificate of Correction***(Identify type of correspondence)*

is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to "Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450" [37 CFR 1.8(a)] on

**8/20/04**  
*(Date)***Sparkle Gunther***(Typed or Printed Name of Person Mailing Correspondence)*  
*(Signature of Person Mailing Correspondence)***Note: Each paper must have its own certificate of mailing.**